


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588103	<b>Applicant(s)/Patent Under Reexamination</b>  MIURA, MINEO
	<b>Examiner</b>  FEI FEI YEUNG LOPEZ	<b>Art Unit</b>  2826

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS	2/21/08	FYL
EAST 257/77 with text search and text search	2/21/08	FYL

INTERFERENCE SEARCH			
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